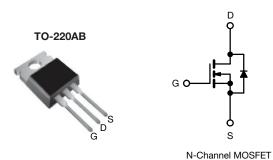


# **Power MOSFET**



| PRODUCT SUMMARY          |                         |     |  |  |
|--------------------------|-------------------------|-----|--|--|
| V <sub>DS</sub> (V)      | 900                     |     |  |  |
| $R_{DS(on)}(\Omega)$     | $V_{GS} = 10 \text{ V}$ | 3.7 |  |  |
| Q <sub>g</sub> max. (nC) | 78                      |     |  |  |
| Q <sub>gs</sub> (nC)     | 10                      |     |  |  |
| Q <sub>gd</sub> (nC)     | 42                      |     |  |  |
| Configuration            | Single                  |     |  |  |

#### **FEATURES**

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>

#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

#### **DESCRIPTION**

Third generation MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION            |                |  |  |
|---------------------------------|----------------|--|--|
| Package                         | TO-220AB       |  |  |
| Lead (Pb)-free                  | IRFBF30PbF     |  |  |
| Lead (Pb)-free and halogen-free | IRFBF30PbF-BE3 |  |  |

| ABSOLUTE MAXIMUM RATINGS $(T_C$                           | = 25 °C, unl            | ess otherwis  | se noted)                         |             |          |  |
|---|-------------------------|---|-----------------------------------|-------------|----------|--|
| PARAMETER   |                         |   | SYMBOL                            | LIMIT       | UNIT     |  |
| Drain-source voltage                                      |                         |   | $V_{DS}$                          | 900         | V        |  |
| Gate-source voltage                                       |                         |   | $V_{GS}$                          | ± 20        | v        |  |
| Continuous drain current                                  | V <sub>GS</sub> at 10 V | $T_{\rm C} = 25  ^{\circ}{\rm C}$<br>$T_{\rm C} = 100  ^{\circ}{\rm C}$ | ,                                 | 3.6         | А        |  |
|   |                         | T <sub>C</sub> = 100 °C   | I <sub>D</sub>                    | 2.3         |          |  |
| Pulsed drain current <sup>a</sup>                         |                         |   | I <sub>DM</sub>                   | 14          | 1        |  |
| Linear derating factor                                    |                         |   |                                   | 1.0         | W/°C     |  |
| Single pulse avalanche energy b                           |                         |   | E <sub>AS</sub>                   | 250         | mJ       |  |
| Repetitive avalanche current <sup>a</sup>                 |                         |   | I <sub>AR</sub>                   | 3.6         | А        |  |
| Repetitive avalanche energy a                             |                         |   | E <sub>AR</sub>                   | 13          | mJ       |  |
| Maximum power dissipation                                 | T <sub>C</sub> = 25 °C  |   | P <sub>D</sub>                    | 125         | W        |  |
| Peak diode recovery dV/dt <sup>c</sup>                    |                         |   | dV/dt                             | 1.5         | V/ns     |  |
| Operating junction and storage temperature range          |                         |   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | - °C     |  |
| Soldering recommendations (peak temperature) <sup>d</sup> | For 10 s                |   |                                   | 300         |          |  |
| Mounting torque   | 6-32 or M3 screw        |   |                                   | 10          | lbf ⋅ in |  |
|   |                         |   |                                   | 1.1         | N · m    |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 36 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 3.6 A (see fig. 12)
- c.  $I_{SD} \le 3.6$  A,  $dI/dt \le 70$  A/ $\mu$ s,  $V_{DD} \le 600$ ,  $T_J \le 150$  °C
- d. 1.6 mm from case



# Vishay Siliconix

| THERMAL RESISTANCE RATINGS          |                   |      |      |      |  |
|-------------------------------------|-------------------|------|------|------|--|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |  |
| Maximum junction-to-ambient         | R <sub>thJA</sub> | -    | 62   |      |  |
| Case-to-sink, flat, greased surface | R <sub>thCS</sub> | 0.50 | -    | °C/W |  |
| Maximum junction-to-case (drain)    | R <sub>thJC</sub> | -    | 1.0  |      |  |

| PARAMETER                                 | SYMBOL   | TES   | MIN.  | TYP. | MAX.   | UNIT  |      |  |
|---|--|---|---|------|--|-------|------|--|
| Static                                    |  |   |   |      |  |       |      |  |
| Drain-source breakdown voltage            | $V_{DS}$                                       | V <sub>GS</sub> :   | 900   | -    | -  | V     |      |  |
| V <sub>DS</sub> temperature coefficient   | $\Delta V_{DS}/T_{J}$                          | Reference   | e to 25 °C, I <sub>D</sub> = 1 mA                                     | -    | 1.1  | -     | V/°C |  |
| Gate-source threshold voltage             | V <sub>GS(th)</sub>                            | V <sub>DS</sub> =   | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                           | 2.0  | -  | 4.0   | V    |  |
| Gate-source leakage                       | I <sub>GSS</sub>                               |   | $V_{GS} = \pm 20 \text{ V}$   |      | -  | ± 100 | nA   |  |
| <b>7</b>                                  | $V_{DS} = 900 \text{ V}, V_{GS} = 0 \text{ V}$ |   | = 900 V, V <sub>GS</sub> = 0 V  | -    | -  | 100   |      |  |
| Zero gate voltage drain current           | I <sub>DSS</sub>                               | V <sub>DS</sub> = 720 \   | /, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                     | -    | -  | 500   | μA   |  |
| Drain-source on-state resistance          | R <sub>DS(on)</sub>                            | V <sub>GS</sub> = 10 V  |   | -    | -  | 3.7   | Ω    |  |
| Forward transconductance                  | 9 <sub>fs</sub>                                | V <sub>DS</sub> =   | 100 V, I <sub>D</sub> = 2.2 A <sup>b</sup>                            | 2.3  | -  | -     | S    |  |
| Dynamic                                   |  |   |   |      |  |       |      |  |
| Input capacitance                         | C <sub>iss</sub>                               | $V_{GS} = 0 V$ ,  |   | -    | 1200   | -     | pF   |  |
| Output capacitance                        | C <sub>oss</sub>                               |   | $V_{\rm DS} = 0 \text{ V},$ $V_{\rm DS} = 25 \text{ V},$              |      | 320  | -     |      |  |
| Reverse transfer capacitance              | C <sub>rss</sub>                               | f = 1.0 MHz, see fig. 5   |   | -    | 200  | -     |      |  |
| Total gate charge                         | Q <sub>g</sub>                                 |   |   | -    | -  | 78    | nC   |  |
| Gate-source charge                        | Q <sub>gs</sub>                                | V <sub>GS</sub> = 10 V  | $I_D = 3.6 \text{ A}, V_{DS} = 360 \text{ V},$<br>see fig. 6 and 13 b | -    | -  | 10    |      |  |
| Gate-drain charge                         | Q <sub>qd</sub>                                |   | See lig. 6 and 13 °   | -    | -  | 42    |      |  |
| Turn-on delay time                        | t <sub>d(on)</sub>                             |   |   | -    | 14   | -     |      |  |
| Rise time                                 | t <sub>r</sub>                                 | V <sub>DD</sub> =   | $V_{DD} = 450 \text{ V}, I_D = 3.6 \text{ A},$                        |      | 25   | -     | ns   |  |
| Turn-off delay time                       | t <sub>d(off)</sub>                            | $R_g = 12 \Omega$ , $R_D = 120 \Omega$ , see fig. 10 b                                |   | -    | 90   | -     |      |  |
| Fall time                                 | t <sub>f</sub>                                 |   |   | -    | 30   | -     |      |  |
| Gate input resistance                     | R <sub>g</sub>                                 | f = 1 MHz, open drain   |   | 0.4  | -  | 2.0   | Ω    |  |
| Internal drain inductance                 | L <sub>D</sub>                                 | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact            |   | -    | 4.5  | -     | .11  |  |
| Internal source inductance                | L <sub>S</sub>                                 |   |   | -    | 7.5  | -     | - nH |  |
| Drain-Source Body Diode Characteristic    | cs   |   |   |      |  |       |      |  |
| Continuous source-drain diode current     | I <sub>S</sub>                                 | MOSFET symbol showing the integral reverse p - n junction diode                       |   | -    | -  | 3.6   | А    |  |
| Pulsed diode forward current <sup>a</sup> | I <sub>SM</sub>                                |   |   | -    | _  | 14    | A    |  |
| Body diode voltage                        | V <sub>SD</sub>                                | $T_J = 25  ^{\circ}\text{C},  I_S = 3.6  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$ |   | -    | -  | 1.8   | V    |  |
| Body diode reverse recovery time          | t <sub>rr</sub>                                | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.6 A, dl/dt = 100 A/µs b                    |   | -    | 430  | 650   | ns   |  |
| Body diode reverse recovery charge        | Q <sub>rr</sub>                                |   |   | -    | 1.4  | 2.1   | μC   |  |
| Forward turn-on time                      | t <sub>on</sub>                                | Intrinsic turn-on time is negligible (turn-   |   |      | n-on is dominated by L <sub>S</sub> and L <sub>D</sub> ) |       |      |  |

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

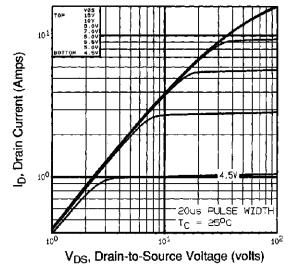


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

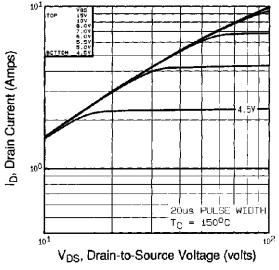


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

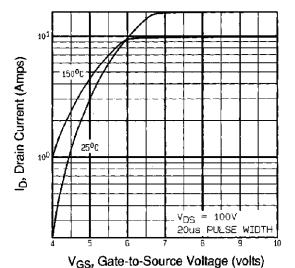


Fig. 3 - Typical Transfer Characteristics

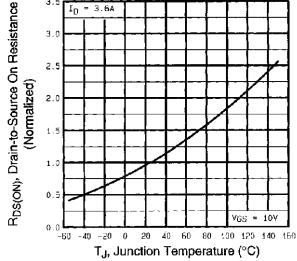


Fig. 4 - Normalized On-Resistance vs. Temperature



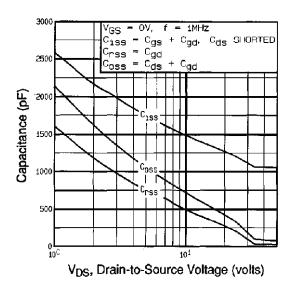


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

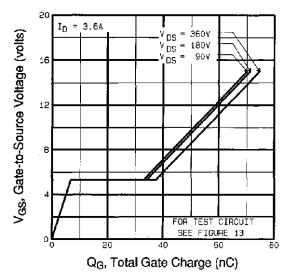


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

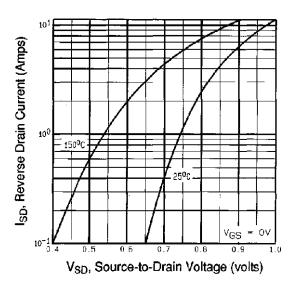


Fig. 7 - Typical Source-Drain Diode Forward Voltage

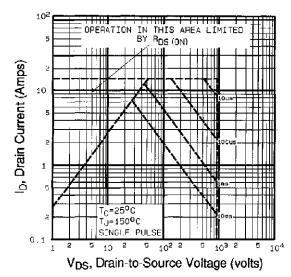


Fig. 8 - Maximum Safe Operating Area



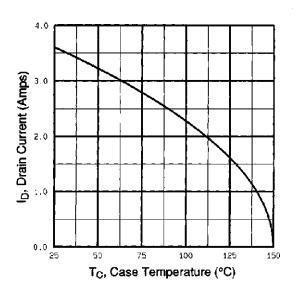


Fig. 9 - Maximum Drain Current vs. Case Temperature

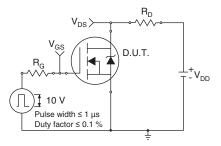


Fig. 10a - Switching Time Test Circuit

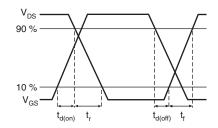


Fig. 10b - Switching Time Waveforms

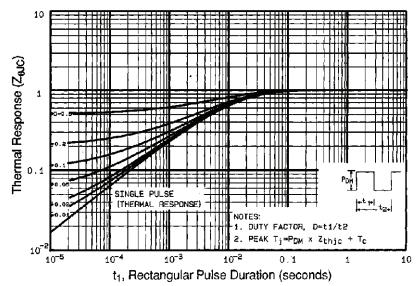


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

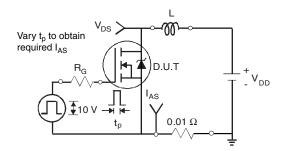


Fig. 12a - Unclamped Inductive Test Circuit

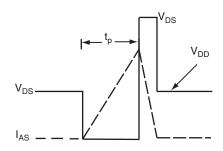


Fig. 12b - Unclamped Inductive Waveforms



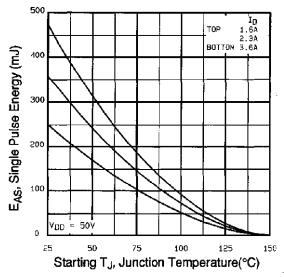


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

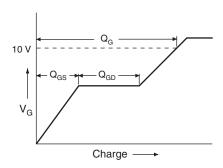


Fig. 13a - Basic Gate Charge Waveform

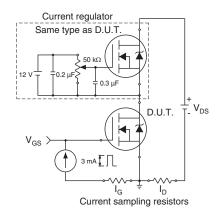
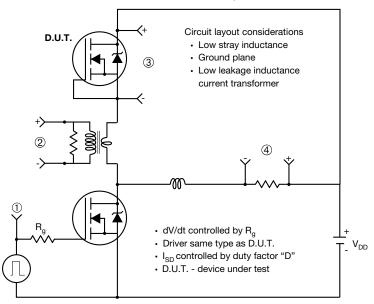


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



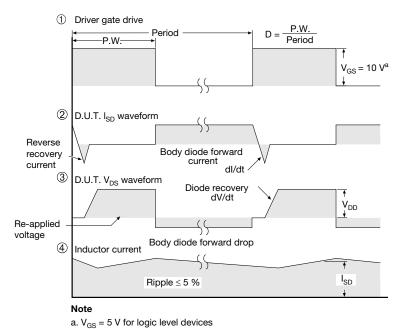


Fig. 14 - For N-Channel

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